

Ref #	Hits	Search Query	DBs	Default Operator	Plurals	Time Stamp
S1	3	@ad<="20011204" and 'IGFET' and 'step' near 'side wall'	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/07/13 08:26
S2	4231	@ad<="20011204" and 'IGFET'	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2002/07/17 09:33
S3	253	@ad<="20011204" and 'IGFET' and 'LDD'	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2002/07/17 14:11
S4	15	@ad<="20011204" and 'IGFET' and 'polycide gate'	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/08/19 07:48
S5	434	@ad<="20011204" and 'IGFET' and 'silicide'	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/05/02 11:08
S6	1	"4777517".PN.	USPAT	OR	OFF	2002/07/17 10:19
S7	1	"4791471".PN..	USPAT	OR	OFF	2002/07/17 10:19
S8	1	"4889817".PN.	USPAT	OR	OFF	2002/07/17 10:19
S9	1	"4905061".PN.	USPAT	OR	OFF	2002/07/17 10:19
S10	1	"5183771".PN.	USPAT	OR	OFF	2002/07/17 10:19
S11	1	"5225286".PN.	USPAT	OR	OFF	2002/07/17 10:19
S12	1	"5243202".PN.	USPAT	OR	OFF	2002/07/17 10:20
S13	1	"5286994".PN.	USPAT	OR	OFF	2002/07/17 10:20
S14	1	"5292673".PN.	USPAT	OR	OFF	2002/07/17 10:20
S15	1	"5528068".PN.	USPAT	OR	OFF	2002/07/17 10:20
S16	1	"5596214".PN.	USPAT	OR	OFF	2002/07/17 10:20
S17	1	"5688724".PN.	USPAT	OR	OFF	2002/07/17 10:20
S18	1	"5866473".PN.	USPAT	OR	OFF	2002/07/17 10:21
S19	1	"5880508".PN.	USPAT	OR	OFF	2002/07/17 10:21
S20	1	"5891798".PN.	USPAT	OR	OFF	2002/07/17 10:21
S21	32	@ad<="20011204" and 'IGFET' and 'polysilicon gate' with 'silicide'	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2003/05/29 08:22

S22	4527	((438/197-209) or (257/262) or (257/326) or (257/368) or (257/334) or (257/347)).CCLS.	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2002/07/17 11:10
S23	350	(438/197).CCLS.	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2002/07/17 11:12
S24	13	((438/197).CCLS.) and @ad<="20011204" and 'IGFET'	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2002/07/17 11:12
S25	1554	@ad<="20001115" and (257/412-413)".ccls"	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/08/19 08:14
S26	229	@ad<="20001115" and (257/388)".ccls"	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2002/12/26 09:37
S27	252	@ad<="20001115" and (438/581-583)".ccls"	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/08/19 08:03
S28	3446	@ad<="20001115" and (438/585-587)".ccls"	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2002/12/26 11:55
S29	268	@ad<="20001115" and (438/588)".ccls"	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/08/19 08:04
S30	1179	@ad<="20001115" and (438/592)".ccls"	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2002/12/26 11:39
S31	6	(("5817562") or ("6083816") or ("5731236")).PN.	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2002/12/26 09:44

S32	3	"0849777"	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2002/12/26 09:45
S33	10	"849777"	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2002/12/26 09:45
S34	2	"07183513"	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2002/12/26 11:39
S35	1005	@ad<="20001115" and (438/585).ccls"	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2002/12/26 11:56
S36	1603	@ad<="20001115" and (257/412-413)".ccls"	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2003/05/29 08:21
S37	657	@ad<="20001115" and (438/585).ccls.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2003/05/29 08:21
S38	1899	@ad<="20001115" and (438/586).ccls.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2003/05/29 08:22
S39	245	@ad<="20001115" and (438/587).ccls.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2003/05/29 08:23
S40	148	@ad<="20001115" and (438/588).ccls.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/07/13 09:03
S41	249	@ad<="20001115" and (438/591).ccls.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2003/05/29 08:23
S42	740	@ad<="20001115" and (438/592).ccls.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2003/05/29 08:23

S43	28	@ad<="20011204" and 'IGFET' and 'silicide gate'	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2003/05/29 09:41
S44	2	anderson-dirk.in.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2003/05/30 08:56
S45	2	("6521963").PN.	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2004/08/19 07:00
S46	39	@ad<="20001115" and 'polycide' adj1 'gate' same 'cap'	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/08/19 07:56
S47	16	@ad<="20001115" and 'polycide' adj1 'gate' same 'etch stop'	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/08/19 07:55
S48	55	@ad<="20001115" and 'polycide' adj1 'gate' same 'LDD'	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/08/19 07:55
S49	271	@ad<="20001115" and 'polycide' adj1 'gate' and 'LDD'	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/05/02 11:54
S50	104	@ad<="20001115" and 'polycide' adj1 'gate' and 'etch stop'	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/08/19 07:56
S51	152	@ad<="20001115" and 'polycide' adj1 'gate' and 'cap'	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/08/19 08:00
S52	2	("6518636").PN.	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2004/08/19 07:59

S53	2	("6342422").PN.	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2004/08/19 08:00
S54	2	("6083816").PN.	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2004/08/19 08:01
S55	2	("5654570").PN.	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2004/08/19 08:01
S56	1066	@ad<="20001115" and (257/412-413).ccls.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/11/14 15:34
S57	765	@ad<="20001115" and (257/410-411).ccls.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/08/19 08:04
S58	153	@ad<="20001115" and (438/581-583).ccls.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/08/19 08:04
S59	149	@ad<="20001115" and (438/588).ccls.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/08/19 08:04
S60	714	@ad<="20001115" and (257/384).ccls"	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/08/19 08:16
S61	1032	@ad<="20001115" and (257/408).ccls.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/08/19 08:22
S62	400	@ad<="20001115" and (257/900).ccls.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/08/19 08:22

S63	640	@ad<="20001115" and (257/336).ccls.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/08/19 08:23
S64	875	@ad<="20001115" and (257/344).ccls.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/08/19 08:24
S65	86	@ad<="20001115" and (257/e21.626).ccls.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/08/19 08:25
S66	1368	@ad<="20001115" and (257/e21.435).ccls.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/08/19 08:26
S67	371	@ad<="20001115" and (257/e29.278).ccls.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/08/19 08:26
S68	2	("6566236").PN.	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2004/12/22 08:05
S69	1	"6235621".PN.	USPAT; USOCR	OR	ON	2004/12/22 08:06
S70	1	"6214709".PN.	USPAT; USOCR	OR	ON	2004/12/22 08:07
S71	2	("6187676").PN.	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2004/12/22 08:15
S72	2	("5817562").PN.	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2004/12/22 08:26
S73	6	(("6319806") or ("6544873") or ("6576939")).PN.	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2004/12/22 08:27

S74	7	@ad<="20011204" and 'IGFET' and 'SAC' and 'cap' and 'nitride'	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/12/22 08:33
S75	1	"20020084482".PN.	US-PGPUB	OR	ON	2004/12/22 08:31
S76	1	"20020001935".PN.	US-PGPUB	OR	ON	2004/12/22 08:31
S77	1	"6436818".PN.	USPAT; USOCR	OR	ON	2004/12/22 08:31
S78	1	"6350665".PN.	USPAT; USOCR	OR	ON	2004/12/22 08:31
S79	1	"6258675".PN.	USPAT; USOCR	OR	ON	2004/12/22 08:32
S80	1	"6200840".PN.	USPAT; USOCR	OR	ON	2004/12/22 08:32
S81	1	"6187676".PN.	USPAT; USOCR	OR	ON	2004/12/22 08:32
S82	16	@ad<="20011204" and 'IGFET' and 'SAC'	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/12/22 08:35
S83	205	@ad<="20011204" and 'FET' and 'SAC'	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/12/22 09:27
S84	150	@ad<="20011204" and 'self aligned contact' same 'MOSFET'	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/12/22 08:43
S85	62	@ad<="20011204" and 'silicide gate' and 'self aligned contact'	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/12/22 10:43
S87	51	@ad<="20011204" and 'silicide' and 'self-align contact' and 'LDI'	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/05/02 12:00
S88	12	@ad<="20011204" and 'IGFET' and 'silicide' and 'SAC'	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/05/02 11:44
S89	16	@ad<="20011204" and 'IGFET' and 'SAC'	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/05/02 11:09

S90	285	@ad<="20001115" and 'polycide' adj1 'gate' and 'LDD' S88	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/05/02 11:37
S91	1	"6030876".PN.	USPAT; USOCR	OR	ON	2005/05/02 11:15
S92	1	"5907188".PN.	USPAT; USOCR	OR	ON	2005/05/02 11:16
S93	1	"5736455".PN.	USPAT; USOCR	OR	ON	2005/05/02 11:16
S94	1	"5132756".PN.	USPAT; USOCR	OR	ON	2005/05/02 11:17
S95	1	"5502320".PN.	USPAT; USOCR	OR	ON	2005/05/02 11:20
S96	1	"5480529".PN.	USPAT; USOCR	OR	ON	2005/05/02 11:20
S97	2	("6566236").PN.	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2005/05/02 11:38
S98	1	"6235621".PN.	USPAT; USOCR	OR	ON	2005/05/02 11:38
S99	1	"6214709".PN.	USPAT; USOCR	OR	ON	2005/05/02 11:38
S100	8	(("6319806") or ("6576939") or ("6458646") or ("5963789")).PN.	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2005/05/02 11:39
S104	237	@ad<="20011204" and 'gate' same 'polysilicon' and 'tungsten silicide' and 'SAC'	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/05/02 11:46
S105	118	@ad<="20011204" and 'gate electrode' same 'polysilicon' and 'tungsten silicide' and 'SAC'	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/05/02 12:13
S106	66	@ad<="20001115" and 'polycide gate' and 'SAC'	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/05/02 11:56
S107	98	@ad<="20001115" and 'polycide gate' and 'self-aligned contact'	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/05/02 11:56

S10 8	52	@ad<="20011204" and 'silicide' and 'self-align contact' and 'LDD'	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/11/14 12:13
S10 9	202	@ad<="20011204" and 'gate electrode' same 'polysilicon' and 'tungsten silicide' and 'self-aligned contact'	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/05/02 12:13
S11 0	65	@ad<="20011204" and ('SAC' or 'self-aligned contact') and 'silicide gate'	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/07/13 09:18
S11 1	149	@ad<="20001115" and (438/588).ccls.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/07/13 09:07
S11 2	2	("6187676").PN.	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2005/07/13 09:08
S11 3	1	"6037246".PN.	USPAT; USOCR	OR	ON	2005/07/13 09:08
S11 4	1	"5962904".PN.	USPAT; USOCR	OR	ON	2005/07/13 09:08
S11 5	1	"5066615".PN.	USPAT; USOCR	OR	ON	2005/07/13 09:08
S11 6	284	@ad<="20011204" and 'polysilicon' with 'silicide' with 'gate' and 'SAC'	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/11/14 12:41
S11 7	4	(("6281084") or ("6146997")).PN.	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2005/07/14 12:22
S11 8	1	"6133098".PN.	USPAT; USOCR	OR	ON	2005/07/14 12:27
S11 9	1	"6049114".PN.	USPAT; USOCR	OR	ON	2005/07/14 12:27
S12 0	1	"6037639".PN.	USPAT; USOCR	OR	ON	2005/07/14 12:27
S12 1	1	"5998290".PN.	USPAT; USOCR	OR	ON	2005/07/14 12:28
S12 2	1	"5877058".PN.	USPAT; USOCR	OR	ON	2005/07/14 12:28
S12 3	1	"5830798".PN.	USPAT; USOCR	OR	ON	2005/07/14 12:28

S12 4	1	"5804856".PN.	USPAT; USOCR	OR	ON	2005/07/14 12:29
S12 5	138	@ad<="20011204" and 'silicide' with 'gate' and 'self-align contact'	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/11/14 12:30
S12 6	52	@ad<="20011204" and 'silicide' and 'self-align contact' and 'LDD'	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/11/14 12:40
S12 7	1	"5998290".PN.	USPAT; USOCR	OR	ON	2005/11/14 12:19
S12 8	1	"5994237".PN.	USPAT; USOCR	OR	ON	2005/11/14 12:19
S12 9	1	"5880035".PN.	USPAT; USOCR	OR	ON	2005/11/14 12:19
S13 0	1	"5698072".PN.	USPAT; USOCR	OR	ON	2005/11/14 12:19
S13 1	2	("6448140").PN.	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2005/11/14 12:30
S13 2	1	"6143611".PN.	USPAT; USOCR	OR	ON	2005/11/14 12:30
S13 3	1	"6001719".PN.	USPAT; USOCR	OR	ON	2005/11/14 12:31
S13 4	1	"5994192".PN.	USPAT; USOCR	OR	ON	2005/11/14 12:32
S13 5	1	"5792684".PN.	USPAT; USOCR	OR	ON	2005/11/14 12:32
S13 6	1	"5792684".PN.	USPAT; USOCR	OR	ON	2005/11/14 12:32
S13 7	223	@ad<="20011204" and 'gate stack' same 'metal silicide'	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/11/14 12:40
S13 8	284	@ad<="20011204" and 'polysilicon' with 'silicide' with 'gate' and 'SAC'	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/11/14 13:48
S13 9	1	"5502320".PN.	USPAT; USOCR	OR	ON	2005/11/14 12:49
S14 0	1	"5480529".PN.	USPAT; USOCR	OR	ON	2005/11/14 12:49
S14 1	1	"5395790".PN.	USPAT; USOCR	OR	ON	2005/11/14 12:50

S14 2	1	"5502320".PN.	USPAT; USOCR	OR	ON	2005/11/14 13:04
S14 3	1	"20010048980".PN.	US-PGPUB	OR	ON	2005/11/14 13:06
S14 4	1	"5943565".PN.	USPAT; USOCR	OR	ON	2005/11/14 13:06
S14 5	1	"5674783".PN.	USPAT; USOCR	OR	ON	2005/11/14 13:06
S14 6	1	"5366586".PN.	USPAT; USOCR	OR	ON	2005/11/14 13:06
S14 7	1	"6323519".PN.	USPAT; USOCR	OR	ON	2005/11/14 13:41
S14 8	1	"6248633".PN.	USPAT; USOCR	OR	ON	2005/11/14 13:42
S14 9	1	"6194294".PN.	USPAT; USOCR	OR	ON	2005/11/14 13:42
S15 0	1	"6191462".PN.	USPAT; USOCR	OR	ON	2005/11/14 13:42
S15 1	1	"6096595".PN.	USPAT; USOCR	OR	ON	2005/11/14 13:42
S15 2	1	"5811357".PN.	USPAT; USOCR	OR	ON	2005/11/14 13:42
S15 3	4	(("6319806") or ("6544873")).PN.	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2005/11/14 14:12
S15 4	2	("6380008").PN.	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2005/11/14 14:39
S15 5	2	("6030876").PN.	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2005/11/15 09:32
S15 6	2	("6531736").PN.	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2005/11/14 14:40
S15 7	1	"5955761".PN.	USPAT; USOCR	OR	ON	2005/11/14 14:41
S15 8	1	"5897365".PN.	USPAT; USOCR	OR	ON	2005/11/14 14:41
S15 9	1	"5882973".PN.	USPAT; USOCR	OR	ON	2005/11/14 14:41

S16 0	1	"5874330".PN.	USPAT; USOCR	OR	ON	2005/11/14 14:41
S16 1	1073	@ad<="20001115" and (257/412-413).ccls.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/11/14 15:34
S16 2	167	@ad<="20001115" and (257/262).ccls.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/11/14 15:34
S16 3	128	@ad<="20001115" and (257/388).ccls.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/11/14 17:10
S16 4	1	"5925918".PN.	USPAT; USOCR	OR	ON	2005/11/14 15:40
S16 5	21	@ad<="20001115" and 'silicide' with 'gate' same 'protrude'	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/11/15 10:06
S16 6	0	'hyeon soo kim'	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/11/15 09:33
S16 7	94	'soo kim'	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/11/15 09:32
S16 8	359	'hyeon' with 'kim'	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/11/15 09:33
S16 9	51	'hyeon' with 'kim' and 'gate electrode'	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/11/15 09:33
S17 1	287	@ad<="20001115" and 'memory cell' with 'peripheral' same 'contacts' same 'source'	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/11/15 10:08
S17 2	0	@ad<="20001115" and 'memory cell' with 'peripheral' same 'contacts' same 'source and drain'	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/11/15 10:08